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Enhanced electromechanical response in Dy³⁺-doped PNN–PZT relaxor ferroelectrics†

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Ferroelectric ceramics with both high piezoelectric coefficients and a wide operational temperature range are in high demand for advanced electromechanical applications. However, since these properties are often mutually exclusive, achieving both exceptional performance and robust thermal stability remains a significant challenge. Here, we report achieving high piezoelectricity ($d_{33} = 840 \text{ pC N}^{-1}$, $k_p = 0.73$, $T_C = 180 \text{ }^\circ\text{C}$) and excellent temperature stability (Δd_{33}^* less than 10% within 20–160 $^\circ\text{C}$) in $0.39\text{Pb}(\text{Ni}_{1/3}\text{Nb}_{2/3})\text{O}_3\text{--}0.59\text{Pb}(\text{Zr}_{0.356}\text{Ti}_{0.644})\text{O}_3\text{--}0.02\text{Pb}(\text{Mg}_{1/2}\text{W}_{1/2})\text{O}_3$ ceramics doped with 0.2 wt% Dy_2O_3 , outperforming those of other typical piezoceramics. Rayleigh analysis, domain writing of PFM, and calculation of the activation energy of domain wall motion reveal that high piezoelectric properties result from enhanced internal contribution and easier domain wall motion. Excellent temperature stability is mainly attributed to the stable domain structure. This work provides a promising direction for the development of piezoelectric materials with both high piezoelectric performance and good temperature stability.

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1. Introduction

Ferroelectrics are renowned for their exceptional ability to convert mechanical energy into electrical energy and *vice versa*. This characteristic has positioned them as promising candidates for a variety of applications, including sensors, actuators, ultrasonic devices, and energy harvesting systems.^{1–3} In recent years, there has been a high demand for ferroelectrics with

high piezoelectric coefficients and a wide operating temperature range for advanced electromechanical applications, such as high-temperature sensors, piezoelectric transducers, and so on.^{4–7} However, the contradiction between high d_{33} and high T_C limits the practical application of ferroelectrics.

Among all ferroelectrics, $\text{Pb}(\text{Zr,Ti})\text{O}_3$ (PZT)-based relaxors with a morphotropic phase boundary (MPB) have been the mainstay ferroelectrics in the last 70 years.^{2,8} Typical PZT-based relaxor systems include $\text{Pb}(\text{Mg,Nb})\text{O}_3\text{--Pb}(\text{Zr,Ti})\text{O}_3$ (PMN–PZT),^{9,10} $\text{Pb}(\text{Zn,Nb})\text{O}_3\text{--Pb}(\text{Zr,Ti})\text{O}_3$ (PZN–PZT),¹¹ and $\text{Pb}(\text{Ni,Nb})\text{O}_3\text{--Pb}(\text{Zr,Ti})\text{O}_3$ (PNN–PZT), among them, the PNN–PZT system has garnered significant research interest due to its ability to achieve an extremely high piezoelectric coefficient by tuning the MPB without doping. The outstanding properties near MPB composition are due to the coexistence of two or more competing ferroelectric phases leading to a flattened free energy profile.⁸ In pursuit of superior piezoelectric performance, researchers have conducted a series of methods on the PNN–PZT system, including the construction of MPB,^{12,13} doping modification,^{14–16} and texturing.¹⁷ However, adjusting the MPB phase boundary or doping modification typically results in a significant deterioration of the Curie temperature (T_C) while enhancing piezoelectric performance (d_{33}).^{13–17} Also, the texturing process is complex and production costs are high.

To achieve a balance between high d_{33} and high T_C , we introduced the high T_C element ($\text{Pb}(\text{Mg,W})\text{O}_3$, PMW) into the PNN–PZT systems.^{18–21} According to literature reports, the PNN–PMW–PZT system has a Curie temperature of around 300 $^\circ\text{C}$, which is much higher than other PNN–PZT systems.

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However, although the PNN-PMW-PZT system has been reported to have a Curie temperature of around 300 °C, the piezoelectric performance is not high.

Therefore, Dy³⁺ was doped into the PNN-PMW-PZT system with the aim of balancing high d_{33} and high T_C . This inspiration comes from the numerous recent literature reports on the promotional effect of rare earth ion doping on the enhancement of performance in relaxor ferroelectric ceramics. The rare earth ions that have been extensively studied include Sm³⁺,^{22–25} Eu³⁺,²⁶ La³⁺,^{27,28} and others. Li *et al.*²⁴ believe that the high piezoelectric performance obtained in Sm³⁺-doped Pb(Mg,Nb)O₃-PbTiO₃ (PMN-PT) ceramics is due to the fact that Sm³⁺ is the smallest ion with an effective ionic radius that can fully occupy the A-site in PMN-PT, inducing a significant local structural heterogeneity. We found that Dy³⁺ has an even smaller ionic radius compared to Sm³⁺, and it is also possible for it to enter the A-site of the perovskite structure. There are relatively few research reports on Dy³⁺ doping in PZT-based relaxor ferroelectrics. However, some studies²⁹ have explored the performance differences caused by doping PZT ceramics with different rare earth elements, with Dy³⁺ doping reported to have a higher relative permittivity (ϵ_r) and remanent polarization (P_r) compared to Sm³⁺ and Eu³⁺ doping. For perovskite ferroelectrics, d_{33} is directly proportional to the product of ϵ_r and P_r .³⁰ Therefore, theoretically, Dy³⁺ doping should also effectively improve the piezoelectric performance of PZT relaxor ferroelectrics.

In this work, Dy³⁺ was doped into the PNN-PMW-PZT system, introducing local structural heterogeneity and achieving excellent comprehensive performance with the d_{33} of 840 pC N⁻¹ and the T_C of 180 °C. In order to explore the origin of the high piezoelectric performance, we conducted Rayleigh analysis under a small electric field to analyze the internal and external contributions, using PFM domain writing to analyze the electric field-induced domain wall motion, and calculated the activation energy for domain wall motion. This work not only enriches the understanding of the role of rare earth doping in relaxor ferroelectrics but also provides a promising direction for the development of high-performance piezoelectric materials.

2. Experimental procedure

The 0.39Pb(Ni_{1/3}Nb_{2/3})O₃-0.59Pb(Zr_{0.356}Ti_{0.644})O₃-0.02Pb(Mg_{1/2}W_{2/3})O₃ + xwt%Dy₂O₃ ceramics were prepared by the traditional solid-state sintering method. The required raw materials were accurately weighed according to the chemical ratio, including Pb₃O₄ (95%), ZrO₂ (99%), TiO₂ (98%), NiO (99%), Nb₂O₅ (99.5%), MgO (99.99%), WO₃ (99%) and Dy₂O₃ (99.9%). After the ingredients were prepared, the raw materials were mixed with zirconia balls and anhydrous ethanol and then placed in a planetary ball mill for grinding for 8 hours. After the ball milling was completed, the evenly mixed slurry was dried and pre-sintered at 820 °C for 2 hours. After grinding the pre-sintered powder for another 8 hours, polyvinyl

alcohol (PVA) aqueous solution was added as a binder for granulation, and then a powder tablet press was used to press and form the tablets under a pressure of 5 MPa to obtain a round sheet with a diameter of 12 mm. In order to reduce the volatilization of lead, the matrix powder was buried during the sintering process to create a sintering atmosphere, and then the crucible was covered and placed in the muffle furnace at a temperature of 1200 °C for 2 hours. The ceramic discs prepared by the solid-state sintering method needed to be metalized on their surfaces to undergo electrical property testing. The specific operation first involves polishing the surface of the sintered ceramic discs to make them smooth, then applying silver paste to the top and bottom surfaces of the discs. The discs were then placed in a muffle furnace to sinter at 600 °C for 10 minutes to plate the silver electrodes. The ceramic discs were immersed in silicone oil at 130 °C, and a direct current (DC) electric field of 30 kV cm⁻¹ was applied to the samples for 15 minutes to polarize them, after which subsequent electrical property testing could be conducted.

The crystal structures of the samples were analyzed using an X-ray diffraction (XRD) analyzer (Bruker D8 Advanced XRD, Bruker AXS Inc., Madison, WI, CuK α) and a Raman spectrometer (DXR2xi, Thermo Fisher Scientific, USA). The PXRD data of the PNN-PZT-PMW-xDy ceramic powder were evaluated by Rietveld refinement using the GSAS software. After polishing the samples, they were thermally etched at 1050 °C for 3 minutes, and their microstructure was observed using a scanning electron microscope (SEM) (JSM-7500LV, Japan Electronics Corporation, Japan). Piezoelectric response force microscopy (PFM) (MFP-3D, Asylum Research, Goleta, CA) was used to observe the domain structure of the polished sample, as well as domain writing. The piezoelectric constant d_{33} is measured using a quasi-static d_{33} tester (ZJ-3A, Institute of Acoustics, Chinese Academy of Sciences). *In situ* temperature-dependent d_{33} was obtained using a high-temperature piezoelectric tester (TZQD-600, Mydream, Shanghai, China). The planar electromechanical coupling coefficient k_p was obtained using an impedance analyzer (HP 4194A, Agilent, Palo Alto, CA, USA). The relative dielectric constant ϵ_r and dielectric loss $\tan \delta$ were determined using an LCR analyzer (HP 4980, Agilent, USA). The temperature dependence of the dielectric parameters ($\epsilon_r/\tan \delta - T$ curve) was measured by the dielectric temperature spectroscopy test system (TZDM-200-300, Harbin Julang Technology Co, Ltd, Harbin, China) with a heating rate of 2 °C min⁻¹ and a temperature range from room temperature to 300 °C. The room temperature and temperature-dependent $P-E$, unipolar $S-E$, and bipolar $S-E$ curves were measured at a frequency of 10 Hz using a ferroelectric analyzer (aixACCT TF Analyzer 2000, Germany).

3. Results and discussion

3.1. Crystal structure

The XRD patterns of the PNN-PZT-PMW-xDy ceramics reveal that all the ceramics exhibit a standard perovskite structure

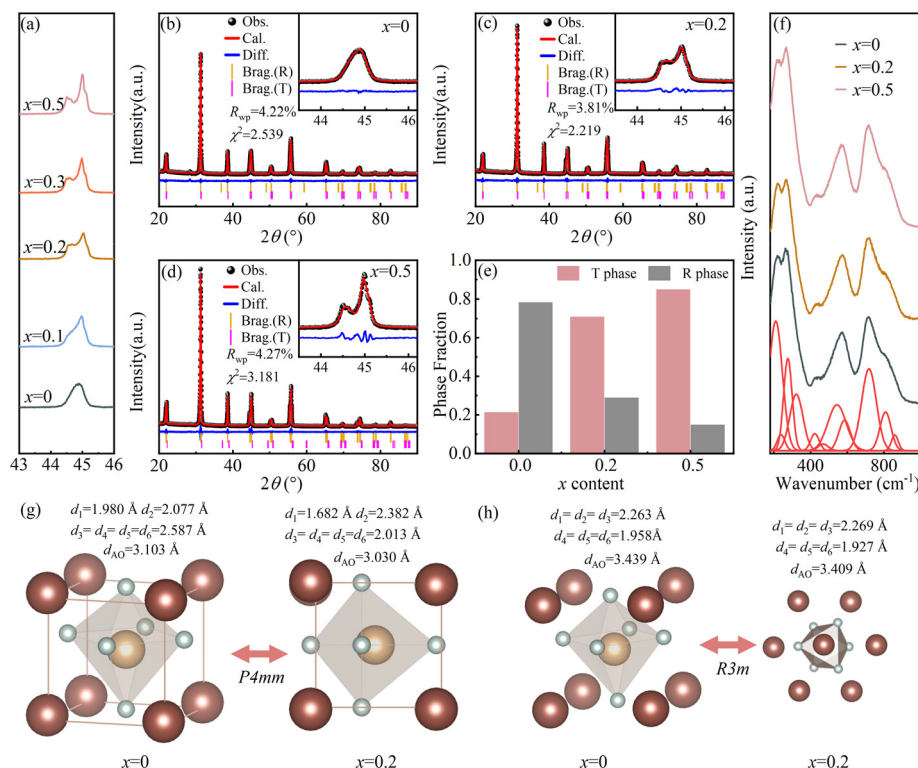


Fig. 1 (a) The enlarged XRD patterns around the Bragg peak position of (200)/(002) with the 2θ range of 43° – 46° . (b and c) Rietveld refinements of the PNN-PZT-PMW-xDy ($x = 0, 0.2$, and 0.5) ceramic powders. (e) Phase fraction as a function of x ($x = 0, 0.2$, and 0.5) content. (f) Raman spectra of the PNN-PZT-PMW-xDy ($x = 0, 0.2$, and 0.5) ceramics. (g and h) Variation of the crystal structure with Dy^{3+} doping.

without other impurity phases, indicating that Dy^{3+} ions are completely incorporated into the PNN-PZT-PMW lattice (Fig. S1†). To facilitate the observation of phase structure variations in samples with different Dy^{3+} doping content, Fig. 1(a) presents enlarged XRD patterns within the 2θ range of 43° – 46° . When x ranges from 0.1 to 0.5, the splitting of the (200) peak indicates the coexistence of the rhombohedral (R) phase and the tetragonal (T) phase.³¹ To further deduce the crystal structure information, the Rietveld refinement analysis of PNN-PZT-PMW-xDy ceramic powders for $x = 0, 0.2$, and 0.5 using the GSAS software is shown in Fig. 1(b–e) and Table S1.† During the refinement process, the initial crystal structures were assumed to be tetragonal ($P4mm$) and rhombohedral ($R3m$) phases, ultimately achieving relatively low R_{wp} and goodness-of-fit indicators (χ^2), suggesting that the refinement results can be considered reliable. From Fig. 1(b–d), it can be seen that the structures of the three compositions contain coexisting T and R phases. Fig. 1(e) presents the phase fraction of the three compositions. With the increase of x content, the fraction of the T phase increases, while the R phase decreases correspondingly. This may be due to the increase in Dy_2O_3 concentration, causing lattice distortion. To substantiate the reliability of the Rietveld results, Fig. 1(f) presents the Raman spectra of the ceramics for $x = 0, 0.2$, and 0.5 , along with their Gaussian peak fitting. Eleven peaks within the range of 200 to 1000 cm^{-1} are obtained, corresponding to eleven distinct

lattice vibrational modes. The intensity of the Raman spectral peaks is related to the lattice symmetry. The ionic radius of Dy^{3+} is 0.912 Å , compared to $r_{Pb^{2+}}$ (1.49 Å) and $r_{Nb^{5+}}$ (0.64 Å), and it is possible to replace the Pb^{2+} and Zr^{4+}/Ti^{4+} ions, respectively. Considering the changes in the lattice constants and unit cell volume provided in Table S1,† the doping of Dy^{3+} leads to a contraction of the unit cell volume, indicating that Dy^{3+} ions preferentially replace Pb^{2+} ions in the perovskite structure.²⁴ Fig. 1(g) and (h) illustrate the R and T crystal structures of the compositions with $x = 0$ and 0.2 , respectively, as derived from the Rietveld refinement results. In Fig. 1(g and h), the bond lengths of the A–O and the six B–O bonds within the perovskite octahedral structure are also indicated, further verifying that the Dy^{3+} ions replace the A-site ions.

3.2. Microstructure

Fig. 2(a–c) present the surface SEM images of the samples with $x = 0, 0.2$, and 0.5 , and Fig. 2(d–f) display the particle size distribution charts of the ceramics. All ceramics exhibit a dense microstructure with few pores and contain both large and small grains. Notably, the grain size significantly increases at $x = 0.2$, which shows the maximum average grain size (G_{ave}) of $3.98\text{ }\mu\text{m}$. This may be due to the substitution of Dy^{3+} for Pb^{2+} , introducing vacancies at the A-site of the lattice, which facilitates the diffusion and migration of ions, thereby promoting grain growth and densification of the ceramic.³² When $x = 0.5$,

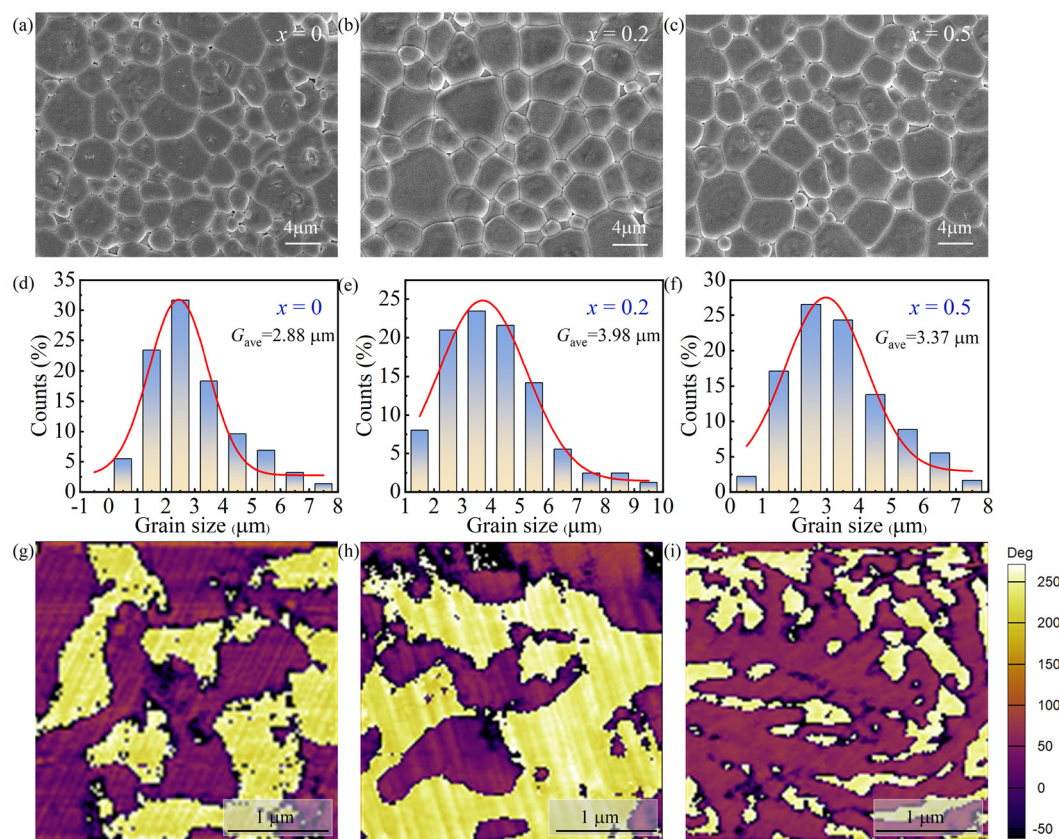


Fig. 2 Surface microstructure, grain size distribution and PFM phase images for the PNN-PZT-PMW- x Dy ceramics with (a, d and g) $x = 0$, (b, e and h) $x = 0.2$, and (c, f and i) $x = 0.5$. The insets of (d–f) denote the average grain size.

the grain size becomes smaller, suggesting that the doping threshold has been reached, inhibiting further grain growth.

Fig. 2(g–i) characterize the phase images of the domain structure of samples with $x = 0, 0.2$ and 0.5 . The domains appear as irregular blocks, with a clear contrast between purple and yellow phase colors visible in Fig. 2(g–i). By comparing the sizes of the irregular blocks, it can be observed that when $x = 0.2$, the domain size is the largest. It can be inferred that the difference in domain size is related to the difference in grain size. The increase in grain size reduces the pinning effect of grain boundaries on domain wall motion, leading to a more pronounced piezoelectric response.¹⁴

3.3. Dielectric properties

To accurately determine the phase transition temperature and investigate the effect of Dy^{3+} doping on the dielectric properties, the temperature dependence of the dielectric spectra was tested for different compositions at various frequencies. Fig. 3(a–c) show the temperature dependence of the ϵ_r and $\tan \delta$ for PNN-PZT-PMW- x Dy ceramics, measured at $f = 0.1, 1, 10, 100$ and 1000 kHz. When the ceramics undergo a phase transition from the ferroelectric to the paraelectric phase, there will be an abrupt change in the relative permittivity with temperature; that is, a dielectric anomaly peak appears, and the temperature corresponding to this peak is the Curie temperature T_C .

In this work, the temperature corresponding to the maximum permittivity T_m is used as an approximation for T_C . From Fig. 3(a–c), with the increase of Dy_2O_3 content, T_C does not show a significant change, and the sample with $x = 0.2$ exhibits a notably higher dielectric constant compared to other compositions.

Since the high piezoelectric performance of lead-based relaxor ferroelectrics is closely related to their relaxor behavior,¹⁴ the influence of Dy_2O_3 content on the relaxor characteristics of PNN-PZT-PMW- x Dy ceramics was further studied. The relaxor behavior of PNN-PZT-PMW- x Dy ceramics was analyzed using the modified Curie-Weiss law, the equation for which is:

$$1/\epsilon_r - 1/\epsilon_m = (T - T_m)^\gamma / C \quad (1)$$

where, C represents the Curie-Weiss constant, and γ indicates the dispersion factor. The insets in Fig. 3(a–c) present the fitting curves of the Curie-Weiss law for different x contents, along with the corresponding dispersion factor γ and Curie-Weiss constant C . The dispersion factor γ of all compositions is between 1.72 and 1.80. The γ of a classical ferroelectric is 1, and that of a completely relaxor ferroelectric is equal to 2.³³ The closer γ is to 2, the stronger the relaxor characteristics the material exhibits. Therefore, the PNN-PZT-PMW- x Dy ceramics are all strong relaxor ferroelectrics. As the content of x

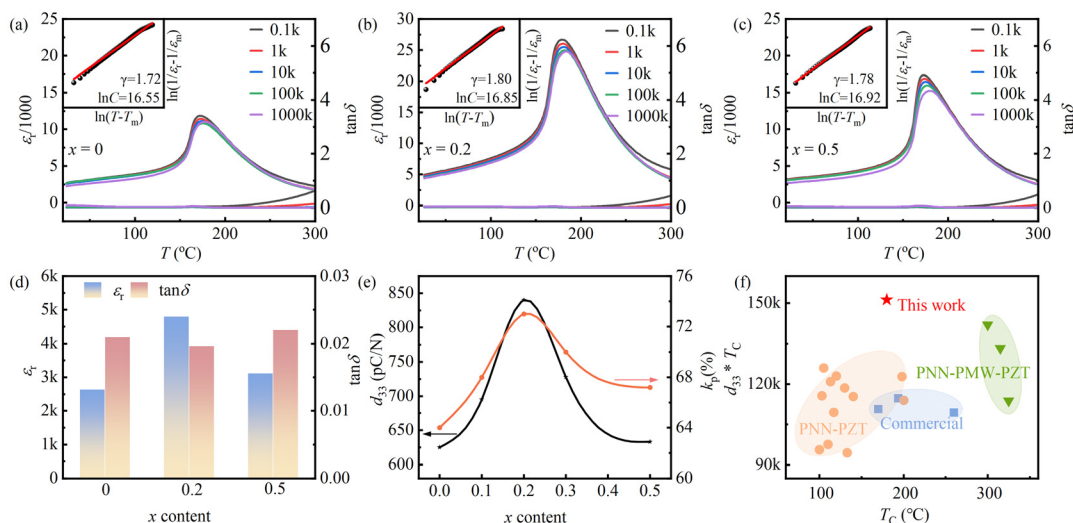


Fig. 3 (a–c) Temperature dependence of $\epsilon_r/1000$ and $\tan \delta$ of unpoled PNN-PZT-PMW-xDy ceramics, measured at $f = 0.1, 1, 10, 100$ and 1000 kHz: (a) $x = 0$, (b) $x = 0.2$, (c) $x = 0.5$. The insets show the plots of $\ln(1/\epsilon_r - 1/\epsilon_m)$ versus $\ln(T - T_m)$ of PNN-PZT-PMW-xDy ceramics. (d) ϵ_r and $\tan \delta$ values of poled PNN-PZT-PMW-xDy ceramics measured at $f = 1$ kHz. (e) d_{33} and k_p values varying with x . (f) Comparison of d_{33} and T_C values of PZT-based ceramics.^{1,3,13–16,36–43}

increases, γ shows a trend of first increasing and then decreasing, with the $x = 0.2$ ceramic having the maximum relaxation ($\gamma = 1.80$). There have been many literature reports on the existence of polar nanoregions (PNRs) in lead-based relaxor ferroelectric systems doped with rare earth elements, and doping with high-valence rare earth elements leads to an increase in PNRs and enhanced local structural heterogeneity.^{34,35} It is inferred that doping Dy^{3+} into PNN-PZT-PMW ceramics would also lead to an increase in PNRs, enhancing local structural heterogeneity, thereby improving piezoelectric performance. The increase in the relaxation degree of the $x = 0.2$ sample can provide some evidence for this inference.

Fig. 3(d) and (e) illustrate the variation of dielectric properties (ϵ_r and $\tan \delta$) and piezoelectric properties (d_{33} and k_p) with the content of x . As the content of Dy_2O_3 increases, ϵ_r , d_{33} , and k_p all exhibit a trend of first increasing and then decreasing, reaching their maximum values when $x = 0.2$, while $\tan \delta$ shows the opposite trend. Fig. 3(f) compares the T_C and $d_{33}^* T_C$ of the current work with those of other related lead-based piezoelectric ceramics. It can be seen from Fig. 3(f) that this work has effectively achieved a balance between d_{33} and T_C for PNN-PZT-based ceramics, with a comprehensive performance superior to other similar lead-based ceramics.

3.4. Ferroelectric properties

Fig. 4(a–c) depict the room-temperature P - E curves, S - E curves, and unipolar S - E curves of the PNN-PZT-PMW-xDy ceramics. All compositions exhibit saturated P - E loops and typical butterfly-shaped S - E curves, indicating that the samples possess good ferroelectricity. Fig. 4(d) and (e) display the ferroelectric parameters extracted from the P - E loops and bipolar S - E curves, including the remanent polarization P_r and the coercive field E_c , as well as the positive strain S_{pos} , negative

strain S_{neg} , and strain at peak-to-peak S_{p-p} . The P_r increases and then decreases with the increase of x content, reaching a maximum at $x = 0.2$, while the trend for E_c is opposite, with the smallest value at $x = 0.2$. The changes in P_r and E_c can be correlated with the previous SEM results, where at $x = 0.2$, the larger grain size reduces the pinning effect on domain wall motion, making the non-180° domains easier to switch, thus increasing P_r and decreasing E_c .⁴⁴ The S_{pos} , S_{neg} , and S_{p-p} all exhibit a trend of increasing first and then decreasing with the increase of x content. At $x = 0.2$, $S_{pos} = 0.14\%$, $S_{neg} = 0.17\%$, and $S_{p-p} = 0.31\%$, demonstrating the best strain performance. As mentioned above, this is also because the larger the grain size, the stronger the constraint on domain wall switching during the reversal of domains, making it more difficult to flip, and the ease of domain wall switching plays a decisive role in the strain performance of piezoelectric materials.⁴⁵ Fig. 4(c) shows that the unipolar strain S_{uni} initially increases with the content of x , reaching the best strain value (0.177%) at $x = 0.2$, and then decreases. To further describe the unipolar strain, the inverse piezoelectric coefficient ($d_{33}^* = S_{uni}/E_{max}$, where S_{uni} is the maximum unipolar strain corresponding to the maximum electric field E_{max}) and strain hysteresis ($H = \Delta S_{E_{max}/2}/S_{uni}$, where $\Delta S_{E_{max}/2}$ is the strain difference at 1/2 of the maximum electric field strength E_{max}) were calculated based on the data in Fig. 4(c), and the changes in d_{33}^* and H values with the content of x are shown in Fig. 4(f). When $x = 0.2$, the d_{33}^* reaches its maximum value of 712 pm V^{-1} , which is inferred to be the result of the increase in both the content of the T phase and the average grain size. In PNN-PZT ceramics, the T phase is more prone to polarization reversal compared to the R phase.⁴⁶ The main source of strain hysteresis is the non-intrinsic contribution from irreversible domain wall motion within the piezoelectric ceramics. Based on the reduction of

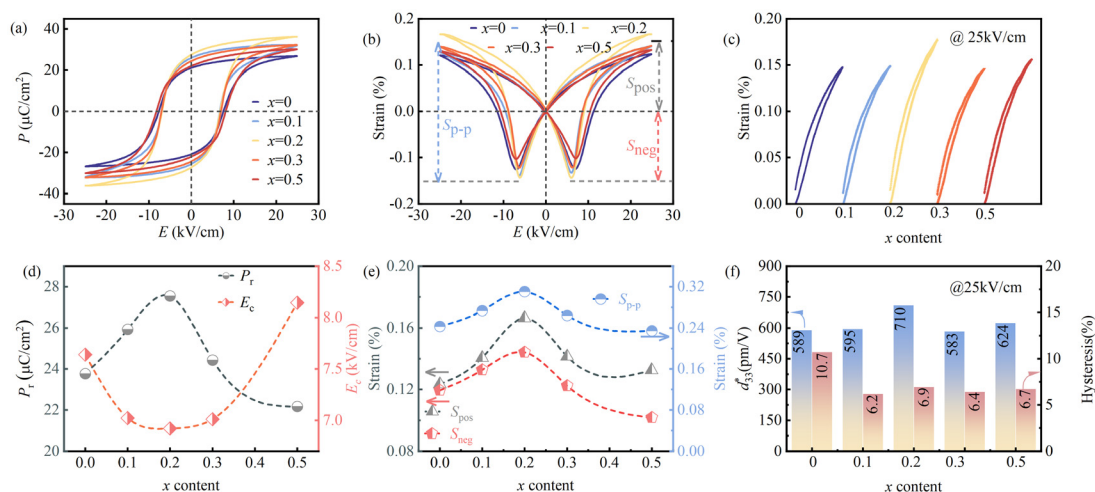


Fig. 4 Ferroelectric and strain properties of the PNN-PZT-PMW- x Dy ceramics: (a) P - E loops; (b) bipolar S - E curves. (c) Unipolar S - E curves. Composition-dependent (d) P_r , E_c , (e) S_{pos} , S_{neg} , S_{p-p} , (f) d_{33}^* , and H values.

strain hysteresis, it is speculated that the doping of Dy_2O_3 enhances the contribution of the intrinsic piezoelectric response strain.

3.5. Origin of piezoelectric properties

In order to explore the origin of the high piezoelectric performance of the PNN-PZT-PMW-0.2Dy ceramic, we conducted an analysis on samples with different compositions using the Rayleigh model. Rayleigh analysis has been proven to be a method for quantifying the contributions of intrinsic lattice distortion and extrinsic domain wall motion to the piezoelectric effect.^{47,48} The Rayleigh model is shown in the following formula:

$$S(E_0) = (d_{init} + \alpha E_0) E_0 \quad (2)$$

$$d_{33}(E_0) = d_{init} + \alpha E_0 \quad (3)$$

In the formula, E_0 represents the applied electric field strength, αE_0 represents the irreversible external contribution from non-180° domain wall motion, and d_{init} represents the reversible piezoelectric contribution, which includes both the internal lattice distortion contribution and the external contribution from reversible domain wall motion. Under high electric fields, the piezoelectric coefficient is mostly derived from the lattice distortion contribution, and the reversible domain wall motion can be neglected. Therefore, d_{init} can be considered the internal contribution, and αE_0 represents the external contribution. Typically, the electric field range responsive to the Rayleigh model is about one-third to one-half of the coercive field, which is well below the coercive field and does not form new domains, exhibiting linear Rayleigh behavior.⁴⁹ Since the electric field range is not sufficient for domain flipping, the strain curve of the sample does not exhibit a “butterfly shape”.

The inverse piezoelectric coefficient can be calculated based on the maximum and minimum strains measured at E_0 , using the following formula:

$$d_{33}(E_0) = (S_{max} - S_{min})/2E_0 \quad (4)$$

Fig. 5(a) shows the S - E curves of the $x = 0.2$ sample tested under different electric fields. The variation of the inverse piezoelectric coefficient d_{33}^* with the applied electric field for different compositions, calculated according to the aforementioned formula, is shown in Fig. 5(b). Linear fitting of the data in Fig. 5(b) yields the intercept and slope of the linear function, which correspond to the d_{init} and α values, representing the internal and external contributions, respectively. The extraction of the fitting results for different compositions is shown in Fig. 5(c), where both d_{init} and α values exhibit a trend of increasing first and then decreasing, reaching their maximum values at $x = 0.2$. This indicates that the internal and external contributions to the ceramic increase when $x = 0.2$, leading to a significant enhancement in piezoelectric performance. The enhancement of the internal lattice distortion contribution is related to the increase in PNRs caused by the doping of the rare earth ion Dy^{3+} , while the enhancement of irreversible external contribution is related to the fact that non-180° domain walls become more prone to switching, which is due to the increased grain size and the lead vacancies resulting from the A-site substitution by the high-valence ions.³² In perovskite ferroelectrics, the piezoelectric coefficient d_{33} can be expressed by the following formula:

$$d_{33} = 2 \times Q \times \epsilon_r \times P_r \quad (5)$$

where, Q is the electrostrictive coefficient, P_r is the remanent polarization, and ϵ_r is the dielectric constant.³⁰ The Q value is generally relatively stable; hence, the piezoelectric coefficient d_{33} is proportional to the product of $\epsilon_r \times P_r$, which follows the same trend with composition variation as shown in Fig. 5(d).

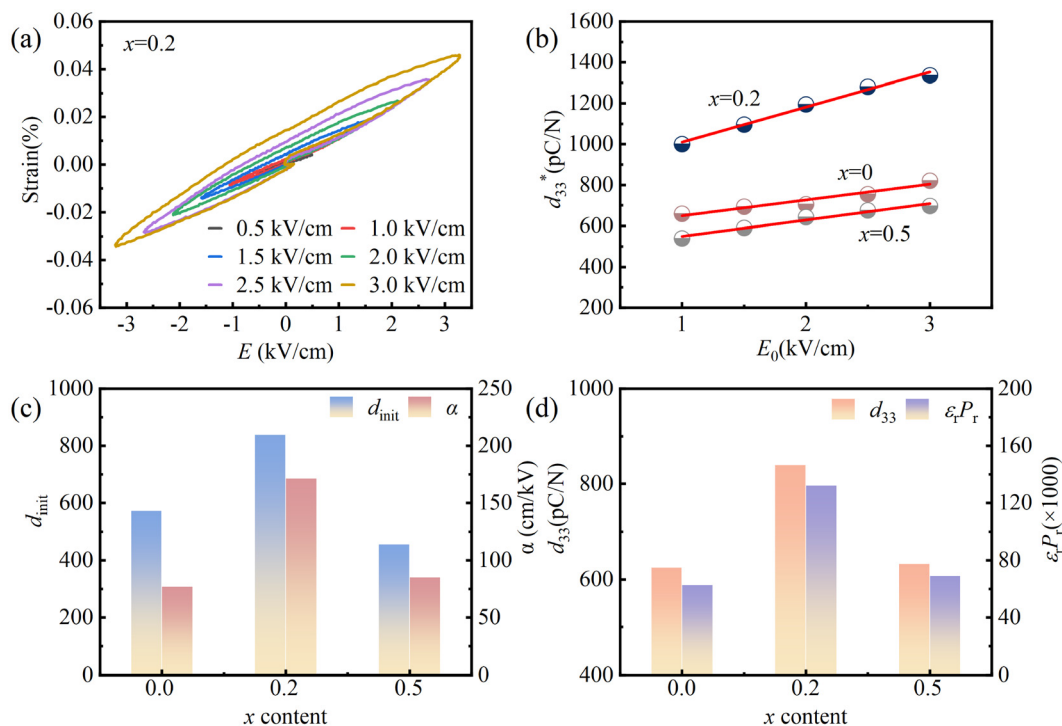


Fig. 5 (a) P - E loops of the ceramics with $x = 0.2$ measured at $f = 10$ Hz. (b) Electric field-dependent d_{33}^* as a function of x ; (c) d_{init} and α values varying with x ; (d) d_{33} and $\epsilon_r P_r$ values varying with x . ϵ_r measured at $f = 1$ kHz.

Since the sample with $x = 0.2$ has the highest values of ϵ_r and P_r , it exhibits the best piezoelectric performance.

Domain writing can be performed using PFM to analyze the electric field-induced domain switching process. Fig. 6(a) and (b) are the domain writing results for the undoped sample and the $x = 0.2$ sample, respectively. Different voltages of 5, 10, 15, and 20 V were applied to the four regions of the sample during the test, as shown in Fig. 6(a) and (b). When the

applied voltage is 5 V, the undoped sample does not exhibit significant domain switching, whereas the $x = 0.2$ sample has already completed the majority of domain switching under the low voltage drive of 5 V. This indicates that the $x = 0.2$ sample has easier domain switching at low voltages, with lower domain wall motion activation energy, which is conducive to improving piezoelectric performance. Additionally, the local domain switching is analyzed using switching spectroscopy

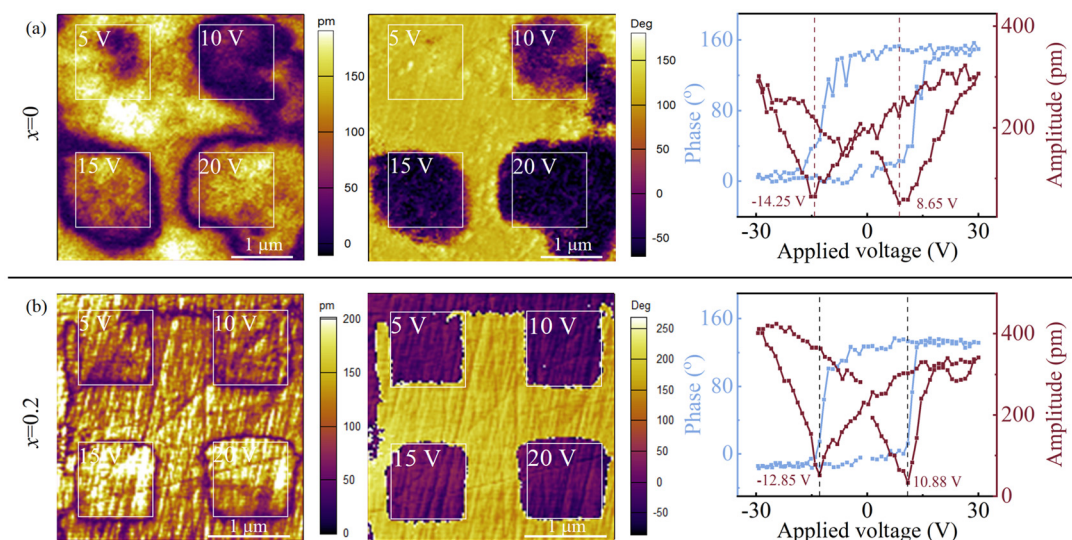


Fig. 6 PFM amplitude and phase images under different electric fields in a square area, and ss-PFM for the ceramics: (a) $x = 0$; (b) $x = 0.2$.

PFM (SS-PFM) loops. Both the undoped sample and the $x = 0.2$ sample exhibit butterfly-shaped amplitudes, indicating benign local domain switching. The amplitude of the $x = 0.2$ ceramic is higher than that of the undoped sample, consistent with their macroscopic ferroelectric/piezoelectric properties. Combined with the results of the Rayleigh analysis in Fig. 5(a–c), it can be concluded that the enhanced internal and external contributions and easier domain wall motion are the sources of the high piezoelectric performance of the $x = 0.2$ sample.

In order to further verify the origin of the high piezoelectric performance of the $x = 0.2$ sample, the activation energy for domain wall motion (E_a) was calculated using the following formula:

$$P_{sr} = P_0 \exp(-E_a/k_B T) \quad (6)$$

In the formula, P_{sr} represents the reverse switching polarization intensity, defined as $P_{sr} = P_s - P_r$, where P_0 and k_B are the fitting constant and the Boltzmann constant, respectively. The polarization reverse switching effect describes that after the removal of the externally applied electric field, the originally highly polarized domains tend to be depolarized to a certain extent under the action of the residual depolarization field, resulting in lower system energy.⁵⁰ By measuring the temperature-dependent P – E curves of samples with different compositions, the P_{sr} at different temperatures can be obtained. Fig. 7(a–e) show scatter plots with the vertical coordinate as $\ln(P_{sr})$ and the horizontal coordinate as $1000/T$, with the black lines representing linear fits obtained. The absolute value of the slope is the activation energy E_a . The variation of E_a with the content of x is given in Fig. 7(f). When $x = 0.2$, the sample has the lowest E_a , and the trend of E_a with Dy_2O_3 content is exactly opposite to the trend of the piezoelectric performance d_{33} . This is because a lower E_a is conducive to domain wall motion, making polarization reversal easier, which is consistent with the analysis of the previous PFM domain writing results.

3.6. Temperature stability

Fig. 8(a) and (d) present the temperature stability of the unipolar strain for the $x = 0.2$ sample under electric fields of 10 kV cm^{-1} and 25 kV cm^{-1} , with the temperature range extending from 20°C to 160°C . Under 10 kV cm^{-1} , the maximum value of the unipolar strain S_{uni} continuously decreases with the increase of temperature, with the maximum S_{uni} at 20°C being 0.096% . However, under the 25 kV cm^{-1} electric field, S_{uni} reaches its maximum value at 120°C , with a maximum of 0.169% . S_{uni} shows little change in the measured temperature range. The amplitudes of the strain extremum variation with temperature for the $x = 0.2$ sample under 10 and 25 kV cm^{-1} electric fields are 0.018 and 0.024 , respectively, indicating excellent strain temperature stability.

To further determine how S_{uni} values change with temperature and the applied electric field, the relationship among S_{uni} , temperature, and electric field for the $x = 0.2$ ceramic is shown in Fig. 8(b), and the relationship among the d_{33}^* , temperature, and electric field is shown in Fig. 8(e). It can be seen from Fig. 8(b) that there is good strain temperature stability under different applied electric fields. From Fig. 8(e), it can be observed that d_{33}^* is significantly greater within the 20 – 100°C range and under an electric field of less than 15 kV cm^{-1} . The strain in piezoelectric materials is equal to the sum of the strains caused by the inverse piezoelectric effect and the electrostrictive effect.³⁷ The smaller d_{33}^* under high electric fields is because the strain caused by the piezoelectric effect is greater than the strain caused by the electrostrictive effect at this time.¹² When a lower electric field is applied, the strain of the $x = 0.2$ ceramic is significantly reduced at high temperatures above 120°C , which is related to the lower strain caused by the inverse piezoelectric effect, and the sample undergoes thermal depolarization.

Fig. 8(c) and (f) compare the temperature stability of d_{33}^* and d_{33} for the $x = 0.2$ sample in this work with those reported in other literature studies for PNN–PZT and the typical com-

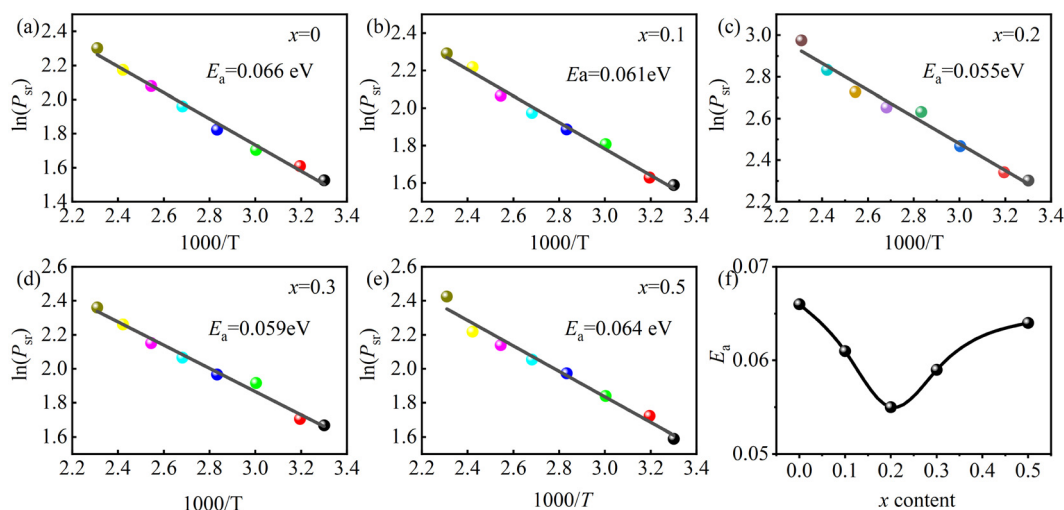


Fig. 7 (a–e) Plot of $\ln(P_{sr})$ as a function of $1000/T$ for $x = 0$ – 0.5 . (f) E_a as a function of x .

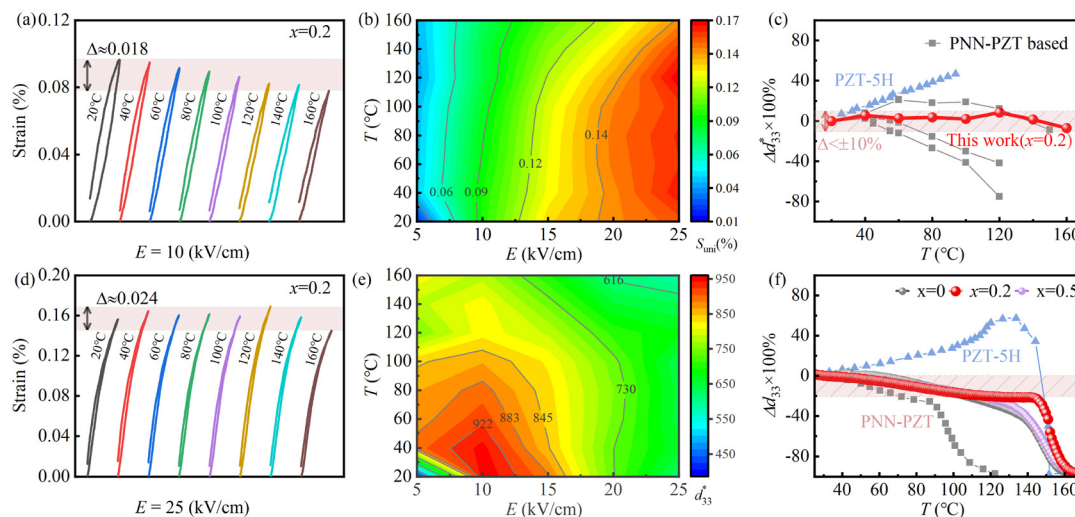


Fig. 8 Unipolar S – E curves of the PNN–PZT–PMW–0.2Dy ceramics from 20 °C to 160 °C: (a) $E = 10$ (kV cm $^{-1}$); (d) $E = 25$ (kV cm $^{-1}$). Temperature- and electric field-dependent (b) S_{uni} and (e) d_{33}^* of the PNN–PZT–PMW–0.2Dy ceramics. Comparison of the temperature stability of (c) d_{33}^* and (f) d_{33} for several reported PZT-based ceramics.^{4,12,37,51,52}

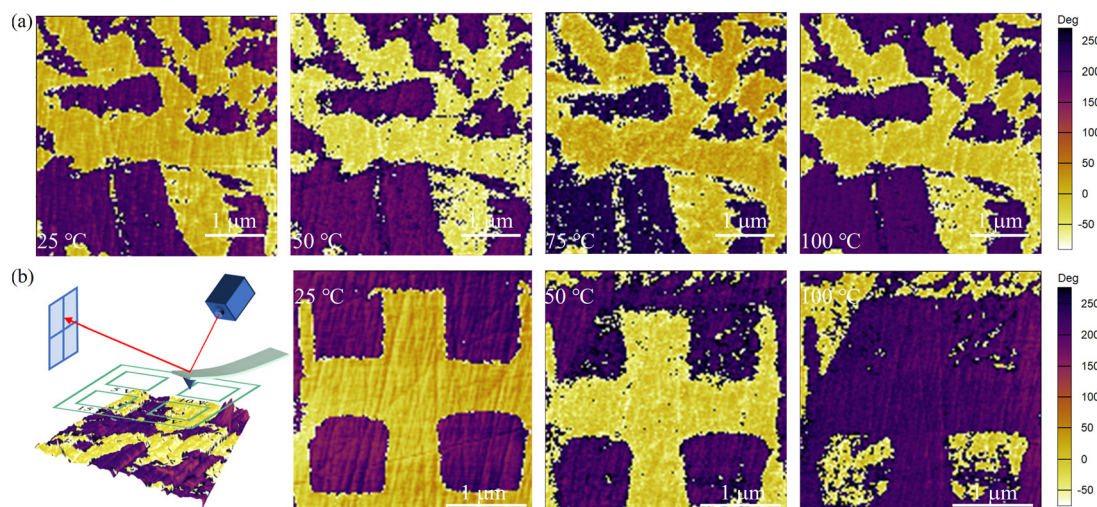


Fig. 9 PFM phase images for the PNN–PZT–PMW–0.2Dy ceramics of (a) the domain after temperature variation (4 × 4 μm) and (b) the temperature variation after domain writing (3 × 3 μm).

mercial ceramic PZT-5H. It can be seen that the strain temperature stability of the $x = 0.2$ sample is better than the temperature stability of d_{33} . The variation of d_{33}^* within the wide temperature range of 20–160 °C is less than $\pm 10\%$; however, d_{33} also exhibits good temperature stability over a broad temperature range, indicating that the $x = 0.2$ ceramic has excellent temperature stability. The reason for the decrease in d_{33} with increasing temperature can be explained by thermal depolarization, which can be illustrated by the temperature-dependent PFM after domain writing. Fig. 9(a) and (b) show the PFM phase images of the domain after temperature variation and the temperature variation after domain writing, respectively. The domains of the $x = 0.2$ sample are essentially unaffected

by temperature within the range of 25–100 °C, exhibiting good temperature stability. Furthermore, the temperature variation after domain writing can reflect the temperature stability of d_{33} . It is only when the temperature rises to 100 °C that the domain response significantly weakens, indicating the occurrence of thermal depolarization.

4. Conclusions

In this work, $0.39\text{Pb}(\text{Ni}_{1/3}\text{Nb}_{2/3})\text{O}_3$ – $0.59\text{Pb}(\text{Zr}_{0.356}\text{Ti}_{0.644})\text{O}_3$ – $0.02\text{Pb}(\text{Mg}_{1/2}\text{W}_{2/3})\text{O}_3 + x\text{wt}\%\text{Dy}_2\text{O}_3$ piezoelectric ceramics are synthesized using a two-step precursor method. High levels of

piezoelectric properties ($d_{33} = 840 \text{ pC N}^{-1}$, $k_p = 0.73$, $T_C = 180 \text{ }^\circ\text{C}$) and temperature stability (Δd_{33}^* less than 10% within 20–160 $^\circ\text{C}$) are obtained in the ceramics with $x = 0.2$, superior to those of reported PZTs and commercially available PZT-5H ceramics. The origin of the high piezoelectricity is attributed to the enhanced internal and external contributions and easier domain wall motion. While good temperature stability originates from a relatively stable domain structure. These advantages make this new material system well-suited for high-performance piezoelectric sensor or actuator applications requiring excellent temperature stability.

Data availability

Data available on request from the authors. The data that support the findings of this study are available from the corresponding author upon reasonable request.

Conflicts of interest

There are no conflicts to declare.

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